To our customers,

## Old Company Name in Catalogs and Other Documents

On April $1^{\text {st }}, 2010$, NEC Electronics Corporation merged with Renesas Technology Corporation, and Renesas Electronics Corporation took over all the business of both companies. Therefore, although the old company name remains in this document, it is a valid Renesas Electronics document. We appreciate your understanding.

Renesas Electronics website: http://www.renesas.com

April ${ }^{\text {st }}, 2010$
Renesas Electronics Corporation

Issued by: Renesas Electronics Corporation (http://www.renesas.com)
Send any inquiries to http://www.renesas.com/inquiry.

## Notice

1. All information included in this document is current as of the date this document is issued. Such information, however, is subject to change without any prior notice. Before purchasing or using any Renesas Electronics products listed herein, please confirm the latest product information with a Renesas Electronics sales office. Also, please pay regular and careful attention to additional and different information to be disclosed by Renesas Electronics such as that disclosed through our website.
2. Renesas Electronics does not assume any liability for infringement of patents, copyrights, or other intellectual property rights of third parties by or arising from the use of Renesas Electronics products or technical information described in this document. No license, express, implied or otherwise, is granted hereby under any patents, copyrights or other intellectual property rights of Renesas Electronics or others.
3. You should not alter, modify, copy, or otherwise misappropriate any Renesas Electronics product, whether in whole or in part.
4. Descriptions of circuits, software and other related information in this document are provided only to illustrate the operation of semiconductor products and application examples. You are fully responsible for the incorporation of these circuits, software, and information in the design of your equipment. Renesas Electronics assumes no responsibility for any losses incurred by you or third parties arising from the use of these circuits, software, or information.
5. When exporting the products or technology described in this document, you should comply with the applicable export control laws and regulations and follow the procedures required by such laws and regulations. You should not use Renesas Electronics products or the technology described in this document for any purpose relating to military applications or use by the military, including but not limited to the development of weapons of mass destruction. Renesas Electronics products and technology may not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable domestic or foreign laws or regulations.
6. Renesas Electronics has used reasonable care in preparing the information included in this document, but Renesas Electronics does not warrant that such information is error free. Renesas Electronics assumes no liability whatsoever for any damages incurred by you resulting from errors in or omissions from the information included herein.
7. Renesas Electronics products are classified according to the following three quality grades: "Standard", "High Quality", and "Specific". The recommended applications for each Renesas Electronics product depends on the product's quality grade, as indicated below. You must check the quality grade of each Renesas Electronics product before using it in a particular application. You may not use any Renesas Electronics product for any application categorized as "Specific" without the prior written consent of Renesas Electronics. Further, you may not use any Renesas Electronics product for any application for which it is not intended without the prior written consent of Renesas Electronics. Renesas Electronics shall not be in any way liable for any damages or losses incurred by you or third parties arising from the use of any Renesas Electronics product for an application categorized as "Specific" or for which the product is not intended where you have failed to obtain the prior written consent of Renesas Electronics. The quality grade of each Renesas Electronics product is "Standard" unless otherwise expressly specified in a Renesas Electronics data sheets or data books, etc.
"Standard": Computers; office equipment; communications equipment; test and measurement equipment; audio and visual equipment; home electronic appliances; machine tools; personal electronic equipment; and industrial robots.
"High Quality": Transportation equipment (automobiles, trains, ships, etc.); traffic control systems; anti-disaster systems; anticrime systems; safety equipment; and medical equipment not specifically designed for life support.
"Specific": Aircraft; aerospace equipment; submersible repeaters; nuclear reactor control systems; medical equipment or systems for life support (e.g. artificial life support devices or systems), surgical implantations, or healthcare intervention (e.g. excision, etc.), and any other applications or purposes that pose a direct threat to human life.
8. You should use the Renesas Electronics products described in this document within the range specified by Renesas Electronics, especially with respect to the maximum rating, operating supply voltage range, movement power voltage range, heat radiation characteristics, installation and other product characteristics. Renesas Electronics shall have no liability for malfunctions or damages arising out of the use of Renesas Electronics products beyond such specified ranges.
9. Although Renesas Electronics endeavors to improve the quality and reliability of its products, semiconductor products have specific characteristics such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Further, Renesas Electronics products are not subject to radiation resistance design. Please be sure to implement safety measures to guard them against the possibility of physical injury, and injury or damage caused by fire in the event of the failure of a Renesas Electronics product, such as safety design for hardware and software including but not limited to redundancy, fire control and malfunction prevention, appropriate treatment for aging degradation or any other appropriate measures. Because the evaluation of microcomputer software alone is very difficult, please evaluate the safety of the final products or system manufactured by you.
10. Please contact a Renesas Electronics sales office for details as to environmental matters such as the environmental compatibility of each Renesas Electronics product. Please use Renesas Electronics products in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. Renesas Electronics assumes no liability for damages or losses occurring as a result of your noncompliance with applicable laws and regulations.
11. This document may not be reproduced or duplicated, in any form, in whole or in part, without prior written consent of Renesas Electronics.
12. Please contact a Renesas Electronics sales office if you have any questions regarding the information contained in this document or Renesas Electronics products, or if you have any other inquiries.
(Note 1) "Renesas Electronics" as used in this document means Renesas Electronics Corporation and also includes its majorityowned subsidiaries.
(Note 2) "Renesas Electronics product(s)" means any product developed or manufactured by or for Renesas Electronics.

## USB 2.0 HOST CONTROLLER


#### Abstract

The $\mu$ PD720102 complies with the universal serial bus specification revision 2.0 and open host controller interface specification for full-/low-speed signaling and Intel's enhanced host controller interface specification for high-speed signaling and works up to 480 Mbps . The $\mu \mathrm{PD} 720102$ is integrated 2 host controller cores with PCI interface and USB 2.0 transceivers into a single chip.


Detailed function descriptions are provided in the following user's manual. Be sure to read the manual before designing. $\mu$ PD720102 User's Manual: S17999E

## FEATURES

- Compliant with universal serial bus specification revision 2.0 (data rate: $1.5 / 12 / 480 \mathrm{Mbps}$ )
- Compliant with open host controller interface specification for USB release 1.0a
- Compliant with enhanced host controller interface specification for USB revision 1.0
- PCI multi-function device consists of one OHCl host controller core for full-/low-speed signaling and one EHCl host controller core for high-speed signaling
- Root hub with 3 (Max.) downstream facing ports which are shared by OHCl and EHCl host controller cores
- All downstream facing ports can handle high-speed ( 480 Mbps ), full-speed (12 Mbps), and low-speed (1.5 Mbps) transaction
- Supports hyper-speed transfer mode using HSMODE signal
- 32-bit 33 MHz host interface compliant with PCI specification revision 2.2
- Supports PCI mobile design guide version 1.1
- Supports PCI-bus power management interface specification revision 1.1
- PCI bus bus-master access
- Supports 3.3 V PCI
- System clock is generated by 30 MHz crystal or 48 MHz clock input
- Operational registers direct-mapped to PCI memory space
- 3.3 V single power supply, 1.5 V internal operating voltage from on chip regulator
- On chip Rs and Rpd resistors for USB signals


## ORDERING INFORMATION

| Part Number | Package | Remark |
| :--- | :--- | :--- |
| $\mu$ PD720102GC-YEB-A | 120-pin plastic TQFP (fine pitch) $(14 \times 14)$ | Lead-free product |
| $\mu$ PD720102F1-CA7-A | 121-pin plastic FBGA $(8 \times 8)$ | Lead-free product |

[^0]
## BLOCK DIAGRAM

## PCI Bus



| PCI Bus Interface | handles 32-bit 33 MHz PCI bus master and target function which comply with PCl specification revision 2.2. The number of enabled ports is set by bit in configuration space. |
| :---: | :---: |
| Arbiter | : arbitrates among two OHCl host controller cores and one EHCl host controller core. |
| OHCI Host Controller | : handles full- (12 Mbps)/low-speed (1.5 Mbps) signaling. |
| EHCI Host Controller | handles high- (480 Mbps) signaling. |
| Root Hub | : handles USB hub function in host controller and controls connection (routing) between host controller core and port. |
| PHY | : consists of high-speed transceiver, full-/low-speed transceiver, serializer, deserializer, etc. |
| INTAO | : is the PCl interrupt signal for OHCl Host Controller. |
| SMIO | is the interrupt signal which is specified by open host controller interface specification for USB release 1.0a and enhanced host controller interface specification revision 1.0. The SMI signal of each OHCl host controller and EHCl host controller appears at this signal. |
| PMEO | is the interrupt signal which is specified by PCI-bus power management interface specification revision 1.1. Wakeup signal of each host controller core appears at this signal. |

## PIN CONFIGURATION

- 120-pin plastic TQFP (fine pitch) ( $14 \times 14$ )
$\mu$ PD720102GC-YEB-A



## Pin Name

- 120-pin plastic TQFP (fine pitch) ( $14 \times 14$ ) $\mu$ PD720102GC-YEB-A

| Pin No. | Pin Name | Pin No. | Pin Name | Pin No. | Pin Name | Pin No. | Pin Name |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | PPON1 | 31 | Vss | 61 | VDD15 | 91 | CLKSEL |
| 2 | OCI20 | 32 | AD23 | 62 | AD12 | 92 | HSMODE |
| 3 | Vss | 33 | AD22 | 63 | AD11 | 93 | TESTEN |
| 4 | PPON2 | 34 | AD21 | 64 | AD10 | 94 | AVss(R) |
| 5 | OCI30 | 35 | AD20 | 65 | Vdo | 95 | RREF |
| 6 | PPON3 | 36 | AD19 | 66 | AD9 | 96 | AV边3 |
| 7 | Vdd | 37 | Vdd | 67 | AD8 | 97 | AVDD15 |
| 8 | VCCRST0 | 38 | AD18 | 68 | CBE00 | 98 | AVss |
| 9 | PME0 | 39 | Vss | 69 | N.C. | 99 | Vss |
| 10 | N.C. | 40 | AD17 | 70 | AD7 | 100 | VDD15 |
| 11 | PCLK | 41 | AD16 | 71 | Vss | 101 | DM1 |
| 12 | Vss | 42 | CBE20 | 72 | AD6 | 102 | DP1 |
| 13 | VBBRST0 | 43 | FRAME0 | 73 | AD5 | 103 | Vss |
| 14 | INTAO | 44 | IRDY0 | 74 | AD4 | 104 | Vss |
| 15 | GNT0 | 45 | Vss | 75 | VDD | 105 | DM2 |
| 16 | REQ0 | 46 | N.C. | 76 | AD3 | 106 | DP2 |
| 17 | AD31 | 47 | TRDYO | 77 | AD2 | 107 | VdD |
| 18 | Vdd | 48 | Vdd | 78 | AD1 | 108 | Vdd |
| 19 | AD30 | 49 | DEVSELO | 79 | AD0 | 109 | DM3 |
| 20 | AD29 | 50 | STOP0 | 80 | Vss | 110 | DP3 |
| 21 | Vss | 51 | PERR0 | 81 | XT1/SCLK | 111 | Vss |
| 22 | AD28 | 52 | SERRO | 82 | N.C. | 112 | VdD |
| 23 | AD27 | 53 | PAR | 83 | XT2 | 113 | N.C. |
| 24 | AD26 | 54 | Vss | 84 | Vdo | 114 | Vss |
| 25 | AD25 | 55 | CBE10 | 85 | CRUNO | 115 | VDD15OUT |
| 26 | AD24 | 56 | AD15 | 86 | SMIO | 116 | Vdd |
| 27 | Vdd | 57 | Vdd | 87 | Vss | 117 | Vdd |
| 28 | CBE30 | 58 | AD14 | 88 | SRCLK | 118 | TEST4 |
| 29 | IDSEL | 59 | AD13 | 89 | SRMOD | 119 | TEST3 |
| 30 | VDD15 | 60 | Vss | 90 | SRDTA | 120 | OCl10 |

Remark $\mathrm{AVss}(\mathrm{R})$ should be used to connect RREF through $1 \%$ precision reference resistor of $1.6 \mathrm{k} \Omega$.

## <R> PIN CONFIGURATION

- 121-pin plastic FBGA (8×8)
$\mu$ PD720102F1-CA7-A

Bottom View

| 21 | 22 | 23 | 24 | 25 | 26 | 27 | 28 | 29 | 30 | 31 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | 11

## Pin name

- 121-pin plastic FBGA $(8 \times 8)$
$\mu$ PD720102F1-CA7-A

| Pin No. | Pin Name | Pin No. | Pin Name | Pin No. | Pin Name | Pin No. | Pin Name |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | DP3 | 32 | RREF | 63 | Vss | 94 | Vdd |
| 2 | PPON1 | 33 | VDD15 | 64 | SMIO | 95 | VDD15OUT |
| 3 | OCI30 | 34 | DM1 | 65 | $\mathrm{AVss}(\mathrm{R})$ | 96 | TEST3 |
| 4 | VCCRST0 | 35 | DP1 | 66 | AV边3 | 97 | Vdd |
| 5 | PCLK | 36 | Vss | 67 | Vss | 98 | Vdd |
| 6 | GNT0 | 37 | DM2 | 68 | Vss | 99 | VdD |
| 7 | AD30 | 38 | DP2 | 69 | Vss | 100 | VdD |
| 8 | AD28 | 39 | Vdd | 70 | Vss | 101 | VDD15 |
| 9 | AD25 | 40 | DM3 | 71 | Vss | 102 | VDD15 |
| 10 | CBE30 | 41 | TEST4 | 72 | Vss | 103 | Vss |
| 11 | Vss | 42 | OCI20 | 73 | OCI10 | 104 | Vss |
| 12 | AD23 | 43 | PPON3 | 74 | PPON2 | 105 | VDD15 |
| 13 | AD21 | 44 | PME0 | 75 | VBBRST0 | 106 | VDD15 |
| 14 | AD18 | 45 | INTA0 | 76 | AD31 | 107 | Vss |
| 15 | CBE20 | 46 | REQ0 | 77 | AD27 | 108 | Vss |
| 16 | TRDY0 | 47 | AD29 | 78 | IDSEL | 109 | Vss |
| 17 | STOP0 | 48 | AD26 | 79 | Vss | 110 | AVss |
| 18 | PAR | 49 | AD24 | 80 | AD19 | 111 | Vdd |
| 19 | AD14 | 50 | AD22 | 81 | AD16 | 112 | Vdd |
| 20 | Vss | 51 | AD20 | 82 | IRDY0 | 113 | VDD |
| 21 | AD12 | 52 | AD17 | 83 | SERR0 | 114 | Vss |
| 22 | AD11 | 53 | FRAME0 | 84 | CBE10 | 115 | Vss |
| 23 | CBE00 | 54 | DEVSEL0 | 85 | AD9 | 116 | Vdd |
| 24 | AD6 | 55 | PERR0 | 86 | AD8 | 117 | VdD |
| 25 | AD3 | 56 | AD15 | 87 | AD4 | 118 | Vdd |
| 26 | AD1 | 57 | AD13 | 88 | AD0 | 119 | VDD |
| 27 | XT1/SCLK | 58 | AD10 | 89 | CRUNO | 120 | VdD |
| 28 | XT2 | 59 | AD7 | 90 | SCLK | 121 | Vdd |
| 29 | SRMOD | 60 | AD5 | 91 | SRDTA |  |  |
| 30 | HSMODE | 61 | AD2 | 92 | CLKSEL |  |  |
| 31 | TESTEN | 62 | Vss | 93 | AVDD15 |  |  |

Remark $\mathrm{AVss}(\mathrm{R})$ should be used to connect RREF through $1 \%$ precision reference resistor of $1.6 \mathrm{k} \Omega$.

## 1. PIN INFORMATION

| Pin Name | I/O <br> Normal (Test) | Buffer Type | Active <br> Level | Function |
| :---: | :---: | :---: | :---: | :---: |
| AD (31:0) | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ |  | PCI "AD [31:0]" signal |
| CBE (3:0)0 | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ |  | PCI "C/BE [3:0]" signal |
| PAR | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ |  | PCI "PAR" signal |
| FRAME0 | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ | Low | PCI "FRAME\#" signal |
| IRDY0 | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ | Low | PCI "IRDY\#" signal |
| TRDYO | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ | Low | PCI "TRDY\#" signal |
| STOPO | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ | Low | PCI "STOP\#" signal |
| IDSEL | I | 3.3 V PCI input with OR input | High | PCI "IDSEL" signal |
| DEVSELO | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ | Low | PCI "DEVSEL\#" signal |
| REQ0 | O (1/O) | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ | Low | PCI "REQ\#" signal |
| GNT0 | I | 3.3 V PCI input with OR input | Low | PCI "GNT\#" signal |
| PERR0 | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ | Low | PCI "PERR\#" signal |
| SERR0 | O (I/O) | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}{ }^{\text {Note } 1}$ | Low | PCI "SERR\#" signal |
| INTAO | O (I/O) | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}{ }^{\text {Note } 1}$ | Low | PCI "INTA\#" signal |
| PCLK | I | 3.3 V PCI input with OR input |  | PCI "CLK" signal |
| VBBRST0 | I | 3.3 V schmitt input | Low | PCI "RST\#" signal |
| CRUN0 | I/O | $3.3 \mathrm{~V} \mathrm{PCI} \mathrm{I/O} \mathrm{with} \mathrm{OR} \mathrm{input}$ | Low | PCI "CLKRUN\#" signal |
| PME0 | 0 | N -ch open drain buffer | Low | PCI "PME\#" signal |
| VCCRST0 | I | 3.3 V schmitt input | Low | PCI "RST\#" signal for D3cold support |
| SMIO | O (1/O) | $3.3 \mathrm{~V} \mathrm{I/O} \mathrm{buffer}$ | Low | System management interrupt output |
| XT1/SCLK | 1 | OSC block |  | System clock input or oscillator in |
| XT2 | 0 | OSC block |  | Oscillator out |
| CLKSEL | I | 3.3 V Input |  | Input clock frequency select signal |
| HSMODE | I | 3.3 V Input | High | Hyper-Speed transfer mode enable signal |
| SRCLK | O (I/O) | $3.3 \mathrm{~V} \mathrm{I/O} \mathrm{buffer}$ |  | Serial ROM clock out |
| SRDTA | I/O | $3.3 \mathrm{~V} \mathrm{I/O} \mathrm{buffer}$ |  | Serial ROM data |
| SRMOD | I | 3.3 V Input with pull down resistor | High | Serial ROM input enable |
| TESTEN ${ }^{\text {Note } 2}$ | I | 3.3 V Input with pull down resistor | High | Test enable pin |
| TEST3 ${ }^{\text {Note } 2}$ | I | 3.3 V Input with pull down resistor | High | Test control |
| TEST4 ${ }^{\text {Note } 2}$ | I | 3.3 V Input with pull down resistor | High | Test control |

Notes 1. These signals become N-ch open drain buffers in normal operation.
2. These pins must be open on board.

| Pin Name | $\begin{gathered} \text { I/O } \\ \text { Normal (Test) } \end{gathered}$ | Buffer Type | Active <br> Level | Function |
| :---: | :---: | :---: | :---: | :---: |
| OCI (3:1)0 | 1 (1/O) | 3.3 V I/O buffer with OR input | Low | USB port's overcurrent status input |
| PPON (3:1) | O (I/O) | 3.3 V I/O buffer | High | USB port's power supply control output |
| DP (3:1) | I/O | USB high speed D+ I/O |  | USB high speed D+ signal |
| DM (3:1) | I/O | USB high speed D-I/O |  | USB high speed D- signal |
| RREF | A | Analog |  | Reference resistor |
| VDD15OUT | 0 | Internal regulator output |  | 1.5 V voltage output from internal regulator |
| VDD15 |  |  |  | 1.5 V VDD from VDD15OUT |
| VDD |  |  |  | 3.3 V VDD |
| AVDD15 |  |  |  | 1.5 V V DD for analog circuit |
| AV ${ }_{\text {dоз }}$ |  |  |  | 3.3 V Vod for analog circuit |
| Vss |  |  |  | Vss |
| AVss |  |  |  | Vss for analog circuit |
| $\mathrm{AVss}(\mathrm{R})$ |  |  |  | Vss for RREF circuit |
| N.C. |  |  |  | No connection |

Remark The signal marked as "(I/O)" in the above table operates as I/O signals during testing. However, they do not need to be considered in normal use.

## 2. HOW TO CONNECT TO EXTERNAL ELEMENTS

### 2.1 Handling Unused Pins

To realize less than 3 ports host controller implementation, appropriate value shall be set to Port No field in EXT1 register. And unused pins shall be connected as shown below.

Table 2-1. Unused Pin Connection

| Pin | Direction | Connection Method |
| :--- | :---: | :--- |
| DPx | I/O | No connection (Open) |
| DMx | I/O | No connection (Open) |
| OCIx | I | "H" clamp |
| PPONx | O | No connection (Open) |

2.2 USB Port Connection

Figure 2-1. USB Downstream Port Connection


### 2.3 Internal Regulator Circuit Connection

Figure 2-2. Internal Regulator Circuit Connection


Caution VDD15OUT must be routed to only VdD15 (and AVdD15). In case that VDD15OUT is also used for power supply of other ICs, this may cause unstable operation of the $\mu$ PD720102.

Remark VDD15 is powered by VDD15OUT from internal regulator. It is not necessary to use external regulator for VDD15.

### 2.4 Analog Circuit Connection

Figure 2-3. Analog Circuit Connection

<R>
Remark The board layout should minimize the total path length from RREF through the resistor to $A V \operatorname{ss}(R)$ and path length to $A V s s$ (analog ground). AVss must be stable.

### 2.5 Crystal Connection

Figure 2-4. Crystal Connection


The following crystals are evaluated on our reference design board. Table 2-2 shows the external parameters.

Table 2-2. External Parameters

| Vender | Crystal | R | C 1 | C 2 |
| :---: | :---: | :---: | :---: | :---: |
| KDS $^{\text {Note } 1}$ | AT-49 30.000 MHz | $100 \Omega$ | 12 pF | 12 pF |
| NDK $^{\text {Note 2 }}$ | AT-41 30.000 MHz | $470 \Omega$ | 10 pF | 10 pF |

Notes 1. DAISHINKU CORP.
2. NIHON DEMPA KOGYO CO., LTD.

In using these crystals, contact KDS or NDK to get the specification on external components to be used in conjunction with the crystal.

KDS's home page: http://www.kds.info/english.html
NDK's home page: http://www.ndk.com/

### 2.6 External Serial ROM Connection

Figure 2-5. External Serial ROM Connection


The following serial ROM is used on our reference design board.

Table 2-3. External Parameters

| Vender | Product name | Size |
| :---: | :---: | :---: |
| Atmel Corporation | AT24C01A-10SC-2.7 | 128 bytes |

SRMOD/SRCLK/SRDTA can be opened, when serial ROM is not necessary on board.

## 3. ELECTRICAL SPECIFICATIONS

### 3.1 Buffer List

- 3.3 V input buffer

CLKSEL, HSMODE

- 3.3 V input buffer with pull down resistor SRMOD, TESTEN, TEST3, TEST4
- 3.3 V input schmitt buffer

VBBRSTO, VCCRSTO

- 3.3 V lol $=9 \mathrm{~mA}$ bi-directional buffer SMIO, PPON(3:1), SRCLK, SRDTA
- $\quad 3.3 \mathrm{~V}$ lol $=9 \mathrm{~mA}$ bi-directional buffer with enable (OR type)
$\mathrm{OCl}(3: 1) 0$
- 3.3 V PCI input buffer with enable (OR type)

IDSEL, GNTO, PCLK

- $\quad 3.3 \mathrm{~V} \mathrm{PCI}$ bi-directional buffer with enable (OR type)

AD(31:0), CBE(3:0)0, PAR, FRAME0, IRDY0, TRDY0, STOP0, DEVSEL0, REQ0, PERR0, SERR0, INTA0, CRUNO

- N-ch open drain buffer PMEO
- 3.3 V oscillator interface XT1/SCLK, XT2
- USB interface, analog signal DP(3:1), DM(3:1), RREF


### 3.2 Terminology

## Terms Used in Absolute Maximum Ratings

| Parameter | Symbol | Meaning |
| :---: | :---: | :---: |
| Power supply voltage | VDD, VDD15, <br> AVддзз, <br> AVDD15 | Indicates the voltage range within which damage or reduced reliability will not result when power is applied to a Vod pin. |
| Input voltage | $\mathrm{V}_{1}$ | Indicates voltage range within which damage or reduced reliability will not result when power is applied to an input pin. |
| Output voltage | Vo | Indicates voltage range within which damage or reduced reliability will not result when power is applied to an output pin. |
| Output current | Io | Indicates absolute tolerance values for DC current to prevent damage or reduced reliability when current flows out of or into output pin. |
| Operating ambient temperature | $\mathrm{T}_{\mathrm{A}}$ | Indicates the ambient temperature range for normal logic operations. |
| Storage temperature | $\mathrm{T}_{\text {stg }}$ | Indicates the element temperature range within which damage or reduced reliability will not result while no voltage or current is applied to the device. |

Terms Used in Recommended Operating Range

| Parameter | Symbol | Meaning |
| :---: | :---: | :---: |
| Power supply voltage | Vdd, AVdd33 | Indicates the voltage range for normal logic operations occur when V ss $=0 \mathrm{~V}$. |
| High-level input voltage | $\mathrm{V}_{\mathrm{IH}}$ | Indicates the voltage, which is applied to the input pins of the device, is the voltage indicates that the high level states for normal operation of the input buffer. <br> If a voltage that is equal to or greater than the "Min." value is applied, the input voltage is guaranteed as high level voltage. |
| Low-level input voltage | VIL | Indicates the voltage, which is applied to the input pins of the device, is the voltage indicates that the low level states for normal operation of the input buffer. <br> * If a voltage that is equal to or lesser than the "Max." value is applied, the input voltage is guaranteed as low level voltage. |
| Hysteresis voltage | $\mathrm{V}_{\mathrm{H}}$ | Indicates the differential between the positive and the negative trigger voltage. |
| Input rise time | tri | Indicates allowable input rise time to input signal transition time from $0.1 \times V_{D D}$ to $0.9 \times$ VD. |
| Input fall time | tfii | Indicates allowable input fall time to input signal transition time from $0.9 \times \mathrm{V}_{\mathrm{DD}}$ to $0.1 \times$ VD. |

## Terms Used in DC Characteristics

| Parameter | Symbol |  |
| :--- | :--- | :--- |
| Off-state output leakage current | loz | Indicates the current that flows from the power supply pins when the rated <br> power supply voltage is applied when a 3-state output has high impedance. |
| Input leakage current | II | Indicates the current that flows when the input voltage is supplied to the input <br> pin. |
| Low-level output current | IoL | Indicates the current that flows to the output pins when the rated low-level <br> output voltage is being applied. |
| High-level output current | loн | Indicates the current that flows from the output pins when the rated high-level <br> output voltage is being applied. |

### 3.3 Electrical Specifications

## Absolute Maximum Ratings

| Parameter | Symbol | Condition | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: |
| Power supply voltage | Vdd, AV的33 |  | -0.5 to +4.6 | V |
|  | VDD15, AV ${ }_{\text {DD15 }}$ |  | -0.5 to +2.0 | V |
| Input voltage, 3.3 V buffer | V | $\mathrm{V}_{1}<\mathrm{V}_{\mathrm{DD}}+0.5 \mathrm{~V}$ | -0.5 to +4.6 | V |
| Output voltage, 3.3 V buffer | Vo | $\mathrm{V}_{0}<\mathrm{V}_{\text {DD }}+0.5 \mathrm{~V}$ | -0.5 to +4.6 | V |
| Output current | Io | 3.3 V buffer (lol $=9 \mathrm{~mA}$ ) PCI buffer | $\begin{aligned} & 29 \\ & 58 \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ |
| Operating ambient temperature | $\mathrm{T}_{\text {A }}$ |  | -20 to +70 | ${ }^{\circ} \mathrm{C}$ |
| Storage temperature | $\mathrm{T}_{\text {stg }}$ |  | -40 to +125 | ${ }^{\circ} \mathrm{C}$ |

Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameters. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.
The ratings and conditions indicated for DC characteristics and AC characteristics represent the quality assurance range during normal operation.

## Recommended Operating Ranges

| Parameter | Symbol | Condition | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Operating voltage | VDD, AV ${ }_{\text {dD33 }}$ |  | 3.135 | 3.3 | 3.465 | V |
| High-level input voltage <br> 3.3 V high-level input voltage | $\mathrm{V}_{\mathrm{H}}$ | VBBRSTO, VCCRSTO <br> Other input pins | $\begin{aligned} & 2.4 \\ & 2.0 \end{aligned}$ |  | $\begin{aligned} & \text { VDD } \\ & V_{D D} \end{aligned}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{v} \end{aligned}$ |
| Low-level input voltage <br> 3.3 V low-level input voltage | VIL | VBBRSTO, VCCRSTO <br> Other input pins | $\begin{aligned} & 0 \\ & 0 \end{aligned}$ |  | $\begin{aligned} & 0.6 \\ & 0.8 \end{aligned}$ | V |
| Hysteresis voltage <br> 3.3 V hysteresis voltage | $\mathrm{V}_{\mathrm{H}}$ |  | 0.3 |  | 1.5 | V |
| Input rise time <br> Normal buffer <br> Schmitt buffer | $\mathrm{tri}^{\text {i }}$ |  | $\begin{aligned} & 0 \\ & 0 \end{aligned}$ |  | $\begin{gathered} 200 \\ 10 \end{gathered}$ | $\begin{aligned} & \mathrm{ns} \\ & \mathrm{~ms} \end{aligned}$ |
| Input fall time <br> Normal buffer <br> Schmitt buffer | $\mathrm{tif}^{\text {l }}$ |  | $\begin{aligned} & 0 \\ & 0 \end{aligned}$ |  | $\begin{gathered} 200 \\ 10 \end{gathered}$ | ns ms |

## DC Characteristics (Vdd =3.135 to 3.465 V, $\mathrm{T}_{\mathrm{A}}=\mathbf{- 2 0}$ to $+70^{\circ} \mathrm{C}$ )

## Control pin block

| Parameter | Symbol | Condition | Min. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Off-state output current | loz | $\mathrm{V}_{\mathrm{O}}=\mathrm{V}_{\text {DD }}$ or $\mathrm{V}_{S S}$ |  | $\pm 10$ | $\mu \mathrm{A}$ |
| Low-level output current <br> 3.3 V low-level output current (9 mA) | IoL | $\mathrm{VoL}=0.4 \mathrm{~V}$ | 9.0 |  | mA |
| High-level output current <br> 3.3 V high-level output current ( 9 mA ) | Іон | Vон $=2.4 \mathrm{~V}$ | -9.0 |  | mA |
| Input leakage current <br> 3.3 V buffer <br> 3.3 V buffer with pull down resistor | I | $\begin{aligned} & V_{I}=V_{D D} \text { or } V_{S S} \\ & V_{I}=V_{D D} \end{aligned}$ |  | $\begin{aligned} & \pm 10 \\ & 175 \end{aligned}$ | $\begin{aligned} & \mu \mathrm{A} \\ & \mu \mathrm{~A} \end{aligned}$ |

## PCI interface block

| Parameter | Symbol | Condition | Min. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| High-level input voltage | VIH |  | 0.5VdD | VDD+0.5 | V |
| Low-level input voltage | VII |  | -0.5 | 0.3 V DD | V |
| Low-level output current | loL | $\mathrm{VoL}=0.1 \mathrm{~V}_{\text {dD }}$ | 1.5 |  | mA |
| High-level output current | Іон | $\mathrm{V}_{\text {OH }}=0.9 \mathrm{~V}$ DD | -0.5 |  | mA |
| Input leakage current | lil | $0<\mathrm{V}_{\text {IN }}<\mathrm{V}_{\text {dD }}$ |  | $\pm 10$ | $\mu \mathrm{A}$ |
| PME0 leakage current | IofF | $\mathrm{Vo}<3.6 \mathrm{~V}$ <br> Vod off or floating |  | 1 | $\mu \mathrm{A}$ |

## USB interface block

| Parameter | Symbol | Conditions | Min. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Output pin impedance | Z HSDRV |  | 40.5 | 49.5 | $\Omega$ |
| Input Levels for Low-/full-speed: |  |  |  |  |  |
| High-level input voltage (drive) | VIH |  | 2.0 |  | V |
| High-level input voltage (floating) | VIHZ |  | 2.7 | 3.6 | V |
| Low-level input voltage | VIL |  |  | 0.8 | V |
| Differential input sensitivity | V ${ }_{\text {I }}$ | $\mid(\mathrm{D}+$ ) - (D-)\| | 0.2 |  | V |
| Differential common mode range | Vcm | Includes Voı range | 0.8 | 2.5 | V |
| Output Levels for Low-/full-speed: |  |  |  |  |  |
| High-level output voltage | Voh | RL of $14.25 \mathrm{k} \Omega$ to GND | 2.8 | 3.6 | V |
| Low-level output voltage | Vol | RL of $1.425 \mathrm{k} \Omega$ to 3.6 V | 0.0 | 0.3 | V |
| SE1 | Vose1 |  | 0.8 |  | V |
| Output signal crossover point voltage | VCrs |  | 1.3 | 2.0 | V |
| Input Levels for High-speed: |  |  |  |  |  |
| High-speed squelch detection threshold (differential signal) | Vhsse |  | 100 | 150 | mV |
| High-speed disconnect detection threshold (differential signal) | Vhsdsc |  | 525 | 625 | mV |
| High-speed data signaling common mode voltage range | V HSCm |  | -50 | +500 | mV |
| High-speed differential input signaling level | See Figu | -2. |  |  |  |
| Output Levels for High-speed: |  |  |  |  |  |
| High-speed idle state | Vhsol |  | -10 | +10 | mV |
| High-speed data signaling high | V HSOH |  | 360 | 440 | mV |
| High-speed data signaling low | V HSOL |  | -10 | +10 | mV |
| Chirp J level (differential signal) | VchirpJ |  | 700 | 1100 | mV |
| Chirp K level (differential signal) | Vchirpk |  | -900 | $-500$ | mV |

Figure 3-1. Differential Input Sensitivity Range for Low-/full-speed


Figure 3-2. Receiver Sensitivity for Transceiver at DP/DM


Figure 3-3. Receiver Measurement Fixtures


## Power consumption

| Parameter | Symbol | Condition | With 30 MHz Crystal |  | With 48 MHz Oscillator |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Typ. | Max. | Typ. | Max. |  |
| Power Consumption | Pwdo-0 | Device state = D0, All the ports does not connect to any function, and each OHCl controller is under USB suspend and EHCl controller is stopped. Note 1 | 11.0 | 16.0 | 3.0 | 7.0 | mA |
|  | Pwoo-1 | The power consumption under the state without suspend. Device state = DO, The number of active ports is 1 . ${ }^{\text {Note } 2}$ <br> Full- or low-speed device is on the port. <br> High-speed device is on the port. | $\begin{aligned} & 15.6 \\ & 60.3 \end{aligned}$ | $\begin{aligned} & 22.6 \\ & 70.8 \end{aligned}$ | $\begin{gathered} 7.7 \\ 60.7 \end{gathered}$ | $\begin{aligned} & 13.5 \\ & 71.3 \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ |
|  | Pwoo-2 | The power consumption under the state without suspend. Device state = DO, The number of active ports is $2 .{ }^{\text {Note } 2}$ <br> Full- or low-speed devices are on the port. <br> High-speed devices are on the port. | $\begin{aligned} & 17.4 \\ & 96.1 \end{aligned}$ | $\begin{gathered} 31.6 \\ 111.8 \end{gathered}$ | $\begin{gathered} 9.5 \\ 96.6 \end{gathered}$ | $\begin{gathered} 22.4 \\ 112.4 \end{gathered}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ |
|  | Pwdo-3 | The power consumption under the state without suspend. Device state = DO, The number of active ports is 3 . ${ }^{\text {Note } 2}$ <br> Full- or low-speed devices are on the port. <br> High-speed devices are on the port. | $\begin{gathered} 18.8 \\ 130.7 \end{gathered}$ | $\begin{gathered} 40.0 \\ 151.8 \end{gathered}$ | $\begin{gathered} 10.8 \\ 131.2 \end{gathered}$ | $\begin{gathered} 31.5 \\ 152.2 \end{gathered}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ |
|  | Pwdo_c | The power consumption under suspend state during PCl clock is stopped by CRUNO. Device state = D0. | 11.0 | 16.0 | 3.0 | 7.0 | mA |
|  | Pwd1 | Device state = D1, Analog PLL output is stopped. ${ }^{\text {Note } 3}$ | 2.1 | 5.9 | 3.0 | 7.0 | mA |
|  | Pwd2 | Device state = D2, Analog PLL output is stopped. ${ }^{\text {Note } 3}$ | 2.1 | 5.9 | 3.0 | 7.0 | mA |
|  | Pwd3\% | Device state $=$ D3hot, VCCRSTO $=$ High, Analog PLL output is stopped. | 2.1 | 5.9 | 3.0 | 7.0 | mA |
|  | Pwdzc | Device state $=$ D3cold, VCCRST0 $=$ Low. ${ }^{\text {Note } 4}$ | 0.03 | 3.0 | 1.38 | 5.2 | mA |

Notes 1. When any device is not connected to all the ports of HC, the power consumption for HC does not depend on the number of active ports.
2. The number of active ports is set by the value of Port No Field in PCI configuration space EXT register.
3. This is the case when PCl bus state is BO .
4. This is the case when PCl bus state is B 3 .

Remark These are estimated value on Windows ${ }^{\text {TM }} \mathrm{XP}$ environment.

Pin capacitance

| Parameter | Symbol | Condition | Min. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Input capacitance | $\mathrm{Cl}_{1}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \\ & \mathrm{fc}=1 \mathrm{MHz} \end{aligned}$ <br> Unmeasured pins returned to 0 V |  | 8 | pF |
| Output capacitance | Co |  |  | 8 | pF |
| I/O capacitance | Cıo |  |  | 8 | pF |
| PCI input pin capacitance | Cin |  |  | 8 | pF |
| PCI clock input pin capacitance | $\mathrm{C}_{\text {clk }}$ |  |  | 8 | pF |
| PCI IDSEL input pin capacitance | CIdSel |  |  | 8 | pF |

AC Characteristics ( $\mathrm{V}_{\mathrm{DD}}=3.135$ to $3.465 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-20$ to $+70^{\circ} \mathrm{C}$ )

## System clock ratings

| Parameter | Symbol | Condition | Min. | Typ. | Max. | Unit |
| :--- | :---: | :--- | :---: | :---: | :---: | :---: |
| Clock frequency | fcık | Crystal | -500 <br> ppm | 30 | +500 <br> ppm | MHz |
|  |  | Oscillator block | -500 <br> ppm | 48 | +500 <br> ppm | MHz |
|  |  |  | 40 | 50 | 60 | $\%$ |

Remarks 1. Recommended accuracy of clock frequency is $\pm 100 \mathrm{ppm}$.
2. Required accuracy of crystal or oscillator block is including initial frequency accuracy, the spread of crystal capacitor loading, supply voltage, temperature, and aging, etc.

## PCI interface block

| Parameter | Symbol | Condition | Min. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| PCI clock cycle time | toyc |  | 30 | 33 | ns |
| PCI clock pulse, high-level width | thigh |  | 11 |  | ns |
| PCI clock pulse, low-level width | tow |  | 11 |  | ns |
| PCI clock, rise slew rate | Scr | $0.2 \mathrm{~V}_{\mathrm{DD}}$ to 0.6VDD | 1 | 4 | V/ns |
| PCI clock, fall slew rate | Scf | 0.2 V do to 0.6Vdd | 1 | 4 | V/ns |
| PCl reset active time (vs. power supply stability) | trst |  | 1 |  | ms |
| PCI reset active time (vs. CLK start) | tst-clik |  | 100 |  | $\mu \mathrm{s}$ |
| Output float delay time (vs. RSTO $\downarrow$ ) | trstoff |  |  | 40 | ns |
| PCI reset rise slew rate | $\mathrm{S}_{\text {Ir }}$ |  | 50 |  | $\mathrm{mV} / \mathrm{ns}$ |
| PCI bus signal output time (vs. PCLK $\uparrow$ ) | tval |  | 2 | 11 | ns |
| PCI point-to-point signal output time (vs. PCLK $\uparrow$ ) | tval (ptp) | REQ0 | 2 | 12 | ns |
| Output delay time (vs. PCLK $\uparrow$ ) | ton |  | 2 |  | ns |
| Output float delay time (vs. PCLK $\uparrow$ ) | toff |  |  | 28 | ns |
| Input setup time (vs. PCLK $\uparrow$ ) | tsu |  | 7 |  | ns |
| Point-to-point input setup time (vs. PCLK $\uparrow$ ) | tsu (ptp) | GNTO | 10 |  | ns |
| Input hold time | th |  | 0 |  | ns |

## USB interface block

| Parameter | Symbol | Conditions | Min. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Low-speed Source Electrical Characteristics |  |  |  |  |  |
| Rise time (10 to 90\%) | tLR | $\begin{aligned} & \mathrm{CL}=200 \text { to } 600 \mathrm{pF}, \\ & \mathrm{Rs}=36 \Omega \end{aligned}$ | 75 | 300 | ns |
| Fall time (90 to 10\%) | tLF | $\begin{aligned} & \mathrm{CL}=200 \text { to } 600 \mathrm{pF}, \\ & \mathrm{Rs}=36 \Omega \end{aligned}$ | 75 | 300 | ns |
| Differential rise and fall time matching | tLRFM | (tLR/tLF) | 80 | 125 | \% |
| Low-speed data rate | tldraths | Average bit rate | 1.49925 | 1.50075 | Mbps |
| Source jitter total (including frequency tolerance): <br> To next transition <br> For paired transitions | todJ1 <br> todj2 |  | $\begin{aligned} & -25 \\ & -14 \end{aligned}$ | $\begin{aligned} & +25 \\ & +14 \end{aligned}$ | $\begin{aligned} & \text { ns } \\ & \text { ns } \end{aligned}$ |
| Source jitter for differential transition to SEO transition | tldeop |  | -40 | +100 | ns |
| Receiver jitter: <br> To next transition <br> For paired transitions | tuJR1 <br> tuJR2 |  | $\begin{aligned} & -152 \\ & -200 \end{aligned}$ | $\begin{aligned} & +152 \\ & +200 \end{aligned}$ | $\begin{aligned} & \text { ns } \\ & \text { ns } \end{aligned}$ |
| Source SE0 interval of EOP | tLEOPT |  | 1.25 | 1.50 | $\mu \mathrm{s}$ |
| Receiver SE0 interval of EOP | tLEOPR |  | 670 |  | ns |
| Width of SEO interval during differential transition | tFST |  |  | 210 | ns |

Full-speed Source Electrical Characteristics

| Rise time (10 to 90\%) | tFR | $\mathrm{CL}=50 \mathrm{pF}$ | 4 | 20 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Fall time (90 to 10\%) | tfF | $\mathrm{CL}=50 \mathrm{pF}$ | 4 | 20 | ns |
| Differential rise and fall time matching | tfram | (tFR/tFF) | 90 | 111.11 | \% |
| Full-speed data rate | trdraths | Average bit rate | 11.9940 | 12.0060 | Mbps |
| Frame interval | tramm |  | 0.9995 | 1.0005 | ms |
| Consecutive frame interval jitter | trFI | No clock adjustment |  | 42 | ns |
| Source jitter total (including frequency tolerance): <br> To next transition For paired transitions | tDJ1 toJ2 |  | $\begin{aligned} & -3.5 \\ & -4.0 \end{aligned}$ | $\begin{aligned} & +3.5 \\ & +4.0 \end{aligned}$ | $\begin{aligned} & \text { ns } \\ & \text { ns } \end{aligned}$ |
| Source jitter for differential transition to SEO transition | tfobeop |  | -2 | +5 | ns |
| Receiver jitter: <br> To next transition <br> For paired transitions | $\begin{aligned} & \mathrm{t}_{\mathrm{R} 1} \\ & \mathrm{t}_{\mathrm{HR} 2} \end{aligned}$ |  | $\begin{gathered} -18.5 \\ -9 \end{gathered}$ | $\begin{gathered} +18.5 \\ +9 \end{gathered}$ | $\begin{aligned} & \text { ns } \\ & \text { ns } \end{aligned}$ |
| Source SEO interval of EOP | tFEOPT |  | 160 | 175 | ns |
| Receiver SEO interval of EOP | treopr |  | 82 |  | ns |
| Width of SEO interval during differential transition | tfst |  |  | 14 | ns |


| Parameter | Symbol | Conditions | Min. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| High-speed Source Electrical Characteristics |  |  |  |  |  |
| Rise time (10 to 90\%) | thSR |  | 500 |  | ps |
| Fall time (90 to 10\%) | thsf |  | 500 |  | ps |
| Driver waveform | See Figure 3-4. |  |  |  |  |
| High-speed data rate | thsdrat |  | 479.760 | 480.240 | Mbps |
| Microframe interval | thsfram |  | 124.9375 | 125.0625 | $\mu \mathrm{s}$ |
| Consecutive microframe interval difference | thSRFI |  |  | 4 high- <br> speed | $\begin{aligned} & \text { Bit } \\ & \text { times } \end{aligned}$ |
| Data source jitter | See Figure 3-4. |  |  |  |  |
| Receiver jitter tolerance | See Figure 3-2. |  |  |  |  |
| Hub Event Timings |  |  |  |  |  |
| Time to detect a downstream facing port connect event | tocnn |  | 2.5 | 2000 | $\mu \mathrm{s}$ |
| Time to detect a disconnect event at a hub's downstream facing port | todis |  | 2.0 | 2.5 | $\mu \mathrm{s}$ |
| Duration of driving resume to a downstream port | torsmon | Nominal | 20 |  | ms |
| Time from detecting downstream resume to rebroadcast | tursm |  |  | 1.0 | ms |
| Inter-packet delay for packets traveling in same direction for high-speed | thsIPdSD |  | 88 |  | $\begin{aligned} & \text { Bit } \\ & \text { times } \end{aligned}$ |
| Inter-packet delay for packets traveling in opposite direction for high-speed | thsipdod |  | 8 |  | $\begin{aligned} & \text { Bit } \\ & \text { times } \end{aligned}$ |
| Inter-packet delay for root hub response for high-speed | thSRSPIPD1 |  |  | 192 | $\begin{gathered} \text { Bit } \\ \text { times } \end{gathered}$ |
| Time for which a Chirp J or Chirp K must be continuously detected during reset handshake | tFlit |  | 2.5 |  | $\mu \mathrm{s}$ |
| Time after end of device Chirp K by which hub must start driving first Chirp K | twtoch |  |  | 100 | $\mu \mathrm{s}$ |
| Time for which each individual Chirp J or Chirp K in the chirp sequence is driven downstream during reset | tochbit |  | 40 | 60 | $\mu \mathrm{s}$ |
| Time before end of reset by which a hub must end its downstream chirp sequence | tochseo |  | 100 | 500 | $\mu \mathrm{s}$ |

Figure 3-4. Transmit Waveform for Transceiver at DP/DM


Figure 3-5. Transmitter Measurement Fixtures


### 3.4 Timing Diagram

PCI clock


PCI reset


PCI output timing measurement condition


PCI input timing measurement condition


## USB differential data jitter for full-speed



USB differential-to-EOP transition skew and EOP width for low-/full-speed


USB receiver jitter tolerance for low-/full-speed


## Low-/full-speed disconnect detection



Full-/high-speed device connect detection


## Low-speed device connect detection



## 4. PACKAGE DRAWINGS

- $\mu$ PD720102GC-YEB-A


## 120-PIN PLASTIC TQFP (FINE PITCH) (14×14)



## NOTE

Each lead centerline is located within 0.07 mm of its true position (T.P.) at maximum material condition.

| ITEM | MILLIMETERS |
| :---: | :--- |
| A | $16.00 \pm 0.20$ |
| B | $14.00 \pm 0.20$ |
| C | $14.00 \pm 0.20$ |
| D | $16.00 \pm 0.20$ |
| F | 1.20 |
| G | 1.20 |
| $H$ | $0.18 \pm 0.05$ |
| I | 0.07 |
| J | 0.40 (T.P.) |
| K | $1.00 \pm 0.20$ |
| L | 0.50 |
| M | $0.17{ }_{-0}^{+0.03}$ |
| N | 0.08 |
| P | $1.00 \pm 0.05$ |
| Q | $0.10 \pm 0.05$ |
| $R$ | $3_{-3}^{\circ+4^{\circ}}$ |
| S | $1.20 M A X$. |
| T | 0.25 |
| U | $0.60 \pm 0.15$ |
|  | P120GC-40-YEB-1 |

## 121-PIN PLASTIC FBGA (8x8)


© NEC Electronics Corporation 2006

## 5. RECOMMENDED SOLDERING CONDITIONS

The $\mu$ PD720102 should be soldered and mounted under the following recommended conditions.
For soldering methods and conditions other than those recommended below, contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

- $\mu$ PD720102GC-YEB-A: 120-pin plastic TQFP (Fine pitch) $(14 \times 14)$

| Soldering Method | Soldering Conditions | Symbol |
| :---: | :---: | :---: |
| Infrared reflow | Peak package's surface temperature: $260^{\circ} \mathrm{C}$, Reflow time: 60 seconds or less ( $220^{\circ} \mathrm{C}$ or higher), Maximum allowable number of reflow processes: 3 , Exposure limit ${ }^{\text {Note }}: 7$ days ( 10 to 72 hours pre-backing is required at $125 \mathrm{C}^{\circ}$ afterwards), <br> Flux: Rosin flux with low chlorine ( $0.2 \mathrm{Wt} \%$ or below) recommended. <br> <Caution> <br> Non-heat-resistant trays, such as magazine and taping trays, cannot be baked before unpacking. | IR60-107-3 |
| Partial heating method | Pin temperature: $350^{\circ} \mathrm{C}$ or below, <br> Heat time: 3 seconds or less (per each side of the device), <br> Flux: Rosin flux with low chlorine ( $0.2 \mathrm{Wt} \%$ or below) recommended. | - |

Note The Maximum number of days during which the product can be stored at a temperature of 5 to $25^{\circ} \mathrm{C}$ and a relative humidity of 20 to $65 \%$ after dry-pack package is opened.
<R> • $\mu$ PD720102F1-CA7-A: 121-pin plastic FBGA $(8 \times 8)$

| Soldering Method | Soldering Conditions | Symbol |
| :---: | :---: | :---: |
| Infrared reflow | Peak package's surface temperature: $260^{\circ} \mathrm{C}$, Reflow time: 60 seconds or less ( $220^{\circ} \mathrm{C}$ or higher), Maximum allowable number of reflow processes: 3 , Exposure limit ${ }^{\text {Note }}: 7$ days ( 10 to 72 hours pre-backing is required at $125 \mathrm{C}^{\circ}$ afterwards), <br> Flux: Rosin flux with low chlorine ( $0.2 \mathrm{Wt} \%$ or below) recommended. <br> <Caution> <br> Non-heat-resistant trays, such as magazine and taping trays, cannot be baked before unpacking. | IR60-107-3 |

Note The Maximum number of days during which the product can be stored at a temperature of 5 to $25^{\circ} \mathrm{C}$ and a relative humidity of 20 to $65 \%$ after dry-pack package is opened.
[MEMO]
[MEMO]

## NOTES FOR CMOS DEVICES

## (1) VOLTAGE APPLICATION WAVEFORM AT INPUT PIN

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between $\mathrm{V}_{\mathrm{IL}}$ (MAX) and $\mathrm{V}_{\mathrm{IH}}$ (MIN) due to noise, etc., the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between VIL (MAX) and VIH (MIN).

## (2) HANDLING OF UNUSED INPUT PINS

Unconnected CMOS device inputs can be cause of malfunction. If an input pin is unconnected, it is possible that an internal input level may be generated due to noise, etc., causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using pull-up or pull-down circuitry. Each unused pin should be connected to VDd or GND via a resistor if there is a possibility that it will be an output pin. All handling related to unused pins must be judged separately for each device and according to related specifications governing the device.

## (3) PRECAUTION AGAINST ESD

A strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it when it has occurred. Environmental control must be adequate. When it is dry, a humidifier should be used. It is recommended to avoid using insulators that easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors should be grounded. The operator should be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with mounted semiconductor devices.

## (4) STATUS BEFORE INITIALIZATION

Power-on does not necessarily define the initial status of a MOS device. Immediately after the power source is turned ON, devices with reset functions have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. A device is not initialized until the reset signal is received. A reset operation must be executed immediately after power-on for devices with reset functions.

## (5) POWER ON/OFF SEQUENCE

In the case of a device that uses different power supplies for the internal operation and external interface, as a rule, switch on the external power supply after switching on the internal power supply. When switching the power supply off, as a rule, switch off the external power supply and then the internal power supply. Use of the reverse power on/off sequences may result in the application of an overvoltage to the internal elements of the device, causing malfunction and degradation of internal elements due to the passage of an abnormal current.
The correct power on/off sequence must be judged separately for each device and according to related specifications governing the device.

## (6) INPUT OF SIGNAL DURING POWER OFF STATE

Do not input signals or an I/O pull-up power supply while the device is not powered. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Input of signals during the power off state must be judged separately for each device and according to related specifications governing the device.

## USB logo is a trademark of USB Implementers Forum, Inc.

## Windows is either a registered trademark or a trademark of Microsoft Corporation in the United States and/or other countries.

- The information in this document is current as of March, 2007. The information is subject to change without notice. For actual design-in, refer to the latest publications of NEC Electronics data sheets or data books, etc., for the most up-to-date specifications of NEC Electronics products. Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.
- No part of this document may be copied or reproduced in any form or by any means without the prior written consent of NEC Electronics. NEC Electronics assumes no responsibility for any errors that may appear in this document.
- NEC Electronics does not assume any liability for infringement of patents, copyrights or other intellectual property rights of third parties by or arising from the use of NEC Electronics products listed in this document or any other liability arising from the use of such products. No license, express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of NEC Electronics or others.
- Descriptions of circuits, software and other related information in this document are provided for illustrative purposes in semiconductor product operation and application examples. The incorporation of these circuits, software and information in the design of a customer's equipment shall be done under the full responsibility of the customer. NEC Electronics assumes no responsibility for any losses incurred by customers or third parties arising from the use of these circuits, software and information.
- While NEC Electronics endeavors to enhance the quality, reliability and safety of NEC Electronics products, customers agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. To minimize risks of damage to property or injury (including death) to persons arising from defects in NEC Electronics products, customers must incorporate sufficient safety measures in their design, such as redundancy, fire-containment and anti-failure features.
- NEC Electronics products are classified into the following three quality grades: "Standard", "Special" and "Specific".
The "Specific" quality grade applies only to NEC Electronics products developed based on a customerdesignated "quality assurance program" for a specific application. The recommended applications of an NEC Electronics product depend on its quality grade, as indicated below. Customers must check the quality grade of each NEC Electronics product before using it in a particular application.
"Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots.
"Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support).
"Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC Electronics products is "Standard" unless otherwise expressly specified in NEC Electronics data sheets or data books, etc. If customers wish to use NEC Electronics products in applications not intended by NEC Electronics, they must contact an NEC Electronics sales representative in advance to determine NEC Electronics' willingness to support a given application.
(Note)
(1) "NEC Electronics" as used in this statement means NEC Electronics Corporation and also includes its majority-owned subsidiaries.
(2) "NEC Electronics products" means any product developed or manufactured by or for NEC Electronics (as defined above).

## Данный компонент на территории Российской Федерации

Вы можете приобрести в компании MosChip.

Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

## http://moschip.ru/get-element

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

Офис по работе с юридическими лицами:
105318, г.Москва, ул.Щербаковская д.3, офис 1107, 1118, ДЦ «Щербаковский»
Телефон: +7 495 668-12-70 (многоканальный)
Факс: +7 495 668-12-70 (доб.304)
E-mail: info@moschip.ru
Skype отдела продаж:
moschip.ru
moschip.ru_6
moschip.ru_4
moschip.ru_9


[^0]:    The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version.
    Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.

